

Search Notes



Application/Control No.

10/757,782

Examiner

José V. Chen

Applicant(s)/Patent under Reexamination

WUNSH ET AL.

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
108	25 26 27 12 14 13 40 161	9/14/15	JLC
206	769 770 326		
UPDATING 5/17/16 JLC			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Frang Bacc Gr Fr 1007-Act	9/20/15	JLC